

Notice of References Cited	Application/Control No. 10/606,799	Applicant(s)/Patent Under Reexamination NOH, WOO YONG	
	Examiner James A. Dudek	Art Unit 2871	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-2004/0141102	07-2004	Lin, Mei-Hui	349/058
	B	US-6,654,078	11-2003	Kato et al.	349/58
	C	US-6,639,635	10-2003	Wang, Ming Tien	349/58
	D	US-6,392,723	05-2002	Sugiyama et al.	349/58
	E	US-6,292,239	09-2001	Nagamura et al.	349/58
	F	US-6,166,788	12-2000	Ha et al.	349/58
	G	US-6,064,455	05-2000	Kim, Yong Gyu	349/113
	H	US-5,929,950	07-1999	Matsuda, Satoru	349/60
	I	US-5,703,665	12-1997	Muramatsu et al.	349/60
	J	US-5,666,172	09-1997	Ida et al.	349/58
	K	US-5,659,376	08-1997	Uehara et al.	349/58
	L	US-5,299,043	03-1994	Taylor et al.	349/58
	M	US-2003/0058380	03-2003	Kim et al.	349/58

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.